

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10/652,486	SANO ET AL.
	Examiner	Art Unit
	Donna V. Lui	2629
		Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0085886	05-2003	Ide et al.	345/211
*	B	US-6,333,738	12-2001	Ide, Shigeo	345/211
	C	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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